Se	arch Notes	

Application/Control No.	Applicant(s)/Patent unde Reexamination	:r
10/629,715	KIM ET AL.	
Examiner	Art Unit	
FRANKIE L. STINSON	1746	

SEARCHED			
Class	Subclass	Date	Examiner
ABOVE	UPDATED	4/1/2007	FLS
,			
<u>-</u>			
· · · · · · · · · · · · · · · · · · ·			
•			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCI		()
	DATE	EXMR
		1
•	+	